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Substitute for form 1449A/B/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

				<i>Complete If Known</i>
Sheet 1 of 3				Application Number 10/036,135-Conf. #3390
				Filing Date November 7, 2001
				First Named Inventor Yeshik Shin
				Art Unit 2665
				Examiner Name S. H. D. Nguyen
				Attorney Docket Number 594728813US

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)				
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Examiner Signature	/Steven Nguyen/	Date Considered	06/11/2006
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Substitute for form 1449A/B/PTO				Complete if Known	
				Application Number	10/036,135-Conf. #3390
				Filing Date	November 7, 2001
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				Art Unit	2665
				Examiner Name	S. H. D. Nguyen
Sheet	2	of	3	Attorney Docket Number	594728813US

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. *CITE NO.: Those application(s) which are marked with an single asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(e)(2)(ii)) because that application was filed after June 30, 2003 or is available in the TFW. *Applicant's unique citation designation number (optional). ²See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS					
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SN	CA	Richmond, Serial protocol elastic buffer description, 07/11/00, 60/217520, Pages 1-13
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